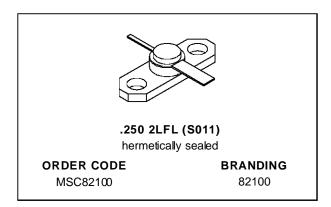


MSC82100

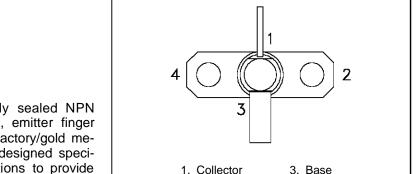
RF & MICROWAVE TRANSISTORS GENERAL PURPOSE LINEAR APPLICATIONS

- EMITTER BALLASTED
- CLASS A LINEAR OPERATION
- COMMON EMITTER
- VSWR CAPABILITY ∞:1 @ RATED CONDITIONS
- ft 1.6 GHz TYPICAL
- NOISE FIGURE 15.5 dB @ 2 GHz
- \blacksquare P_{OUT} = 27 dBm MIN. @ 1.0 GHz



PIN CONNECTION

4. Emitter



2. Emitter

DESCRIPTION

The MSC82100 is a hermetically sealed NPN power transistor with a fishbone, emitter finger ballasted geometry utilizing a refractory/gold metallization system. The device is designed specifically for Class A linear applications to provide high gain and high output power at the 1.0 dB compression point.

ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

Symbol	Parameter	Value	Unit
P _{DISS}	Power Dissipation (see Safe Area)	_	W
Ic	Device Bias Current	200	mA
V _{CE}	Collector-Emitter Bias Voltage*	20	V
TJ	Junction Temperature	200	°C
T _{STG}	Storage Temperature	- 65 to +200	°C

THERMAL DATA

R _{TH(j-c)}	Junction-Case Thermal Resistance*	20	°C/W

 $^{^*}$ Applies only to rated RF amplifier operation

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ELECTRICAL SPECIFICATIONS (T_{case} = 25°C)

STATIC

Symbol	Test Conditions	Value			11:4		
		Min.	Тур.	Max.	Unit		
BV _{CBO}	I _C = 1mA	$I_E = 0mA$		45	_		V
BV _{EBO}	I _E = 1mA	$I_C = 0mA$		3.5	_	_	V
BVceo	IC = 5mA	$I_B = 0mA$		20	_	_	V
ICEO	V _{CE} = 18V			_	_	0.5	mA
h _{FE}	V _{CE} = 5V	I _C = 100mA		15	_	120	_

DYNAMIC

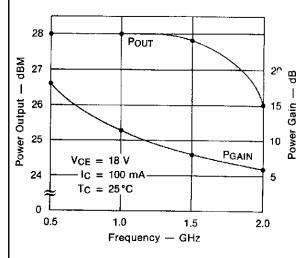
Cumbal	Took Conditions		Value		IImi4		
Symbol	Test Conditions			Min.	Тур.	Max.	Unit
G _P *	f = 1.0 GHz	$P_{OUT} = 27 \text{ dBm}$		10.5	11.5	_	dB
ΔG_P^*	f = 1.0 GHz	$P_{OUT} = 27 \text{ dBm}$	$\Delta P_{OUT} = 10 \text{ dB}$	_	_	1	dB
СОВ	f = 1 MHz	$V_{CB} = 28 \text{ V}$		_	_	3.2	pF

* Note: $V_{CE} = 18V$ $I_{C} = 100 \text{mA}$

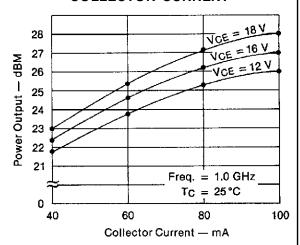


TYPICAL PERFORMANCE

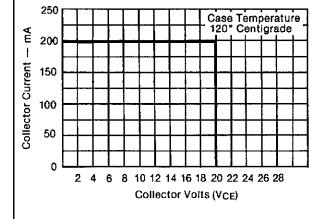




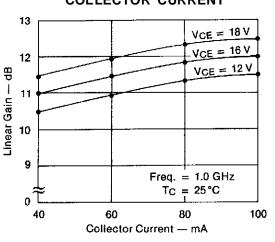
TYPICAL POWER OUTPUT & GAIN @ 1dB COMPRESSION POINT vs COLLECTOR CURRENT



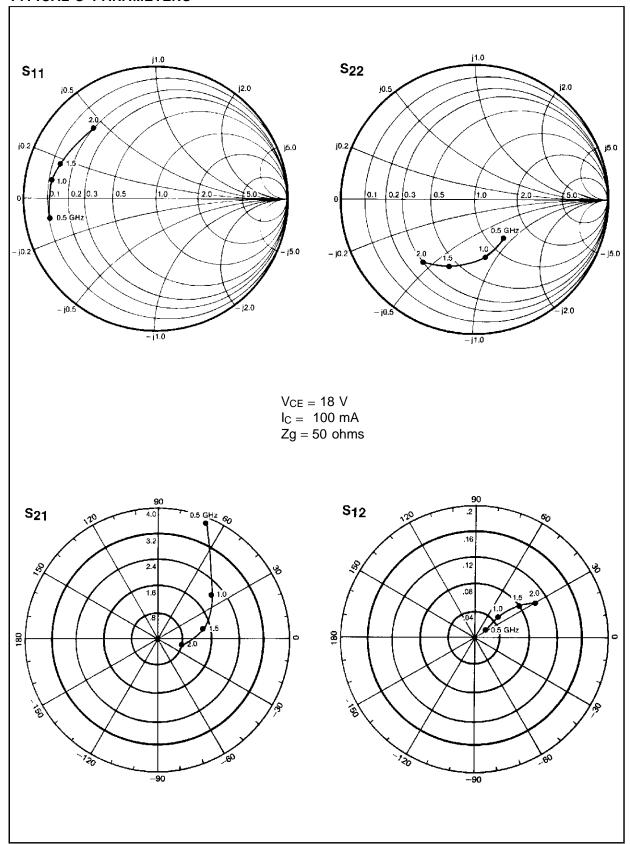
MAXIMUM OPERATING AREA FOR FORWARD BIAS OPERATION



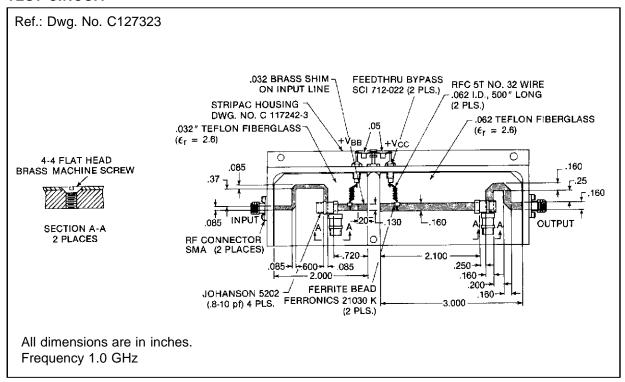
TYPICAL LINEAR GAIN vs COLLECTOR CURRENT



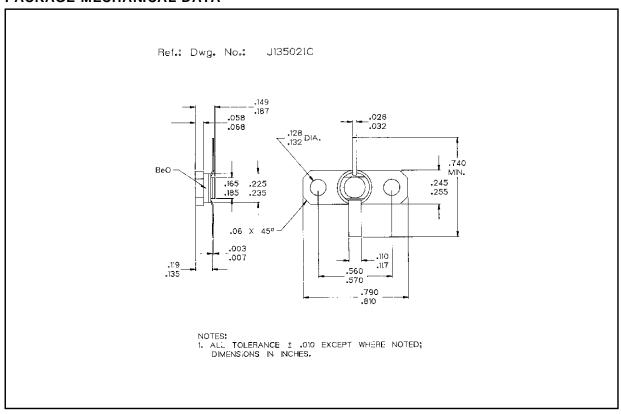
TYPICAL S-PARAMETERS



TEST CIRCUIT



PACKAGE MECHANICAL DATA



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